

**AMENDMENTS TO THE CLAIMS:**

This listing of claims will replace all prior versions, and listings, of claims in the application:

**LISTING OF CLAIMS:**

1. (Currently Amended) High-power press pack semiconductor module,  
(1) comprising:

- an electrically conducting base plate (4);
- at least one electrically conducting top plate (3);
- at least one semiconductor chip (2) including semiconductor material, a first main electrode that makes contact with the base plate forming a plane interface and a second main electrode that makes contact with the top plate,
- a housing (11, 12, 13) containing the base plate, top plate and semiconductor chip,

wherein a material is provided adjacent at least one of said first or second main electrodes that, together with the semiconductor material forms an a eutectic alloy or an alloy whose melting point is below that of the semiconductor material, characterized in, that and wherein

- at least one of said base plate (4) or top plate (3) is made of metal matrix composite material comprising of two-dimensional randomly distributed short cut graphite fibers in the plane of the interface in an Al or Ag matrix, whose coefficient of thermal expansion is close to that of the semiconductor material, said metal matrix composite material containing said alloy-forming material.

2. (Currently Amended) Module as claimed in claim 1, characterized in, that wherein:

- said base plate (4) and top plate (3) are made of the same metal matrix composite material.

3. (Currently Amended) Module as claimed in claim 1, characterized in, that wherein:

- said metal matrix composite material has a metal content of at least 25 percent by volume.

4. (Currently Amended) Module as claimed in claim 3, characterized in, that wherein:

- said metal matrix composite material comprises a metallic matrix alloy with a semiconductor material.

5. (Currently Amended) High-power press pack semiconductor module (1) comprising:

- an electrically conducting base plate (4);
- at least one electrically conducting top plate (3);
- at least one semiconductor chip (2) including semiconductor material, a first main electrode that makes contact with the base plate forming a plane interface and a second main electrode that makes contact with the top plate,
- a housing (11, 12, 13) containing the base plate, top plate and semiconductor chip,

wherein a material is provided adjacent at least one of said first or second main electrodes that, together with the semiconductor material forms an a eutectic alloy or an alloy whose melting point is below that of the semiconductor material, and wherein

- at least one of said base plate (4) or top plate (3) is made of metal matrix composite material comprising of two-dimensional randomly distributed short cut graphite fibers in the plane of the interface in an Al or Ag matrix, whose coefficient of thermal expansion is close to that of the semiconductor material, said metal matrix composite material containing said alloy-forming material,

- said metal matrix composite material has having a metal content of at least 25 percent by volume,

- said metal matrix composite material comprises comprising a metallic matrix alloy with a semiconductor material, and

- said metallic matrix alloy has having a semiconductor material content up to the semiconductor material content of an a eutectic composition.

6. (Currently Amended) Module as claimed in claim 5, characterized in, that wherein:

- said matrix comprises Ag, Al, Au or Cu with a Si content of at most 13 percent.

7. (Currently Amended) Module as claimed in claim 4, characterized in, that wherein:

- said metallic matrix alloy has a semiconductor material content that is tailored depending on the thickness of the semiconductor material such that the hotspot alloy is in the eutectic range without bulk precipitation.

8. (Currently Amended) Module as claimed in claim 1, characterized in, that wherein:

- said at least one plate of a metal matrix composite material (3, 4) has a thickness of at least the thickness of the semiconductor material.

9. (Currently Amended) Module as claimed in claim 1, characterized in, that wherein:

- said base plate (4) and said top plate (3) are both made of metal matrix composite material, and

- said plates (3, 4) have a combined thickness of at least the thickness of the semiconductor material.